



## General Description:

CS25N50 ANR the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-3P (N) , which accords with the RoHS standard.

## Features:

- **Fast Switching**
- **Low ON Resistance**( $R_{ds(on)} \leq 0.27\Omega$ )
- **Low Gate Charge** (Typical Data:64 nC)
- **Low Reverse transfer capacitances**(Typical: 10pF)
- **100% Single Pulse avalanche energy Test**

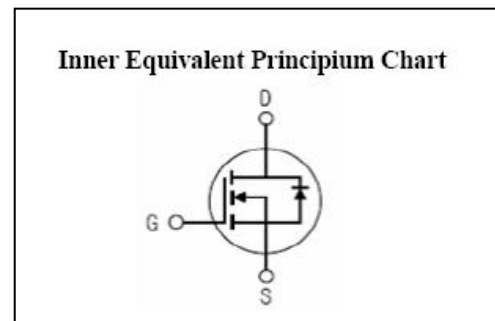
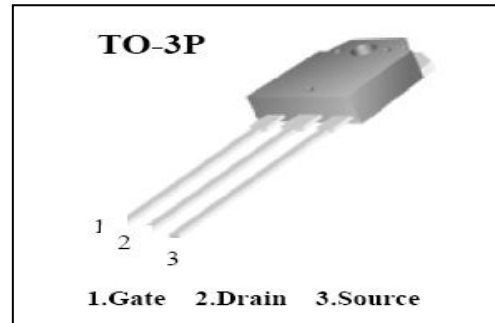
## Applications:

Power switch circuit of adaptor and charger.

**Absolute** (Tc= 25°C unless otherwise specified):

| Symbol                            | Parameter                                        | Rating          | Units |
|-----------------------------------|--------------------------------------------------|-----------------|-------|
| V <sub>DSS</sub>                  | Drain-to-Source Voltage                          | 500             | V     |
| I <sub>D</sub>                    | Continuous Drain Current                         | 25              | A     |
|                                   | Continuous Drain Current T <sub>C</sub> = 100 °C | 15.7            | A     |
| I <sub>DM</sub> <sup>a1</sup>     | Pulsed Drain Current                             | 100             | A     |
| V <sub>GS</sub>                   | Gate-to-Source Voltage                           | ± 30            | V     |
| E <sub>AS</sub> <sup>a2</sup>     | Single Pulse Avalanche Energy                    | 1500            | mJ    |
| dv/dt <sup>a3</sup>               | Peak Diode Recovery dv/dt                        | 5.0             | V/ns  |
| P <sub>D</sub>                    | Power Dissipation                                | 300             | W     |
|                                   | Derating Factor above 25°C                       | 2.4             | W/°C  |
| T <sub>J</sub> , T <sub>stg</sub> | Operating Junction and Storage Temperature Range | 150, -55 to 150 | °C    |
| T <sub>L</sub>                    | Maximum Temperature for Soldering                | 300             | °C    |

|                                       |      |   |
|---------------------------------------|------|---|
| V <sub>DSS</sub>                      | 500  | V |
| I <sub>D</sub>                        | 25   | A |
| P <sub>D</sub> (T <sub>C</sub> =25°C) | 300  | W |
| R <sub>DS(ON)Typ</sub>                | 0.21 | Ω |





**Electrical Characteristics** (T<sub>c</sub>= 25℃ unless otherwise specified):

| OFF Characteristics                    |                                   |                                                                       |        |      |      |       |
|----------------------------------------|-----------------------------------|-----------------------------------------------------------------------|--------|------|------|-------|
| Symbol                                 | Parameter                         | Test Conditions                                                       | Rating |      |      | Units |
|                                        |                                   |                                                                       | Min.   | Typ. | Max. |       |
| V <sub>DSS</sub>                       | Drain to Source Breakdown Voltage | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA                            | 500    | --   | --   | V     |
| Δ BV <sub>DSS</sub> / Δ T <sub>J</sub> | Bvdss Temperature Coefficient     | I <sub>D</sub> =250uA, Reference 25℃                                  | --     | 0.6  | --   | V/℃   |
| I <sub>DSS</sub>                       | Drain to Source Leakage Current   | V <sub>DS</sub> =500V, V <sub>GS</sub> = 0V,<br>T <sub>a</sub> = 25℃  | --     | --   | 1    | μA    |
|                                        |                                   | V <sub>DS</sub> =400V, V <sub>GS</sub> = 0V,<br>T <sub>a</sub> = 125℃ | --     | --   | 100  | μA    |
| I <sub>GSS(F)</sub>                    | Gate to Source Forward Leakage    | V <sub>GS</sub> =+30V                                                 | --     | --   | 100  | nA    |
| I <sub>GSS(R)</sub>                    | Gate to Source Reverse Leakage    | V <sub>GS</sub> =-30V                                                 | --     | --   | -100 | nA    |

| ON Characteristics             |                               |                                                            |        |      |      |       |
|--------------------------------|-------------------------------|------------------------------------------------------------|--------|------|------|-------|
| Symbol                         | Parameter                     | Test Conditions                                            | Rating |      |      | Units |
|                                |                               |                                                            | Min.   | Typ. | Max. |       |
| R <sub>DS(ON)</sub>            | Drain-to-Source On-Resistance | V <sub>GS</sub> =10V, I <sub>D</sub> =12.5A                | --     | 0.21 | 0.27 | Ω     |
| V <sub>GS(TH)</sub>            | Gate Threshold Voltage        | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA | 2.0    | --   | 4.0  | V     |
| Pulse width tp ≤ 300μs, δ ≤ 2% |                               |                                                            |        |      |      |       |

| Dynamic Characteristics |                              |                                                          |        |      |      |       |
|-------------------------|------------------------------|----------------------------------------------------------|--------|------|------|-------|
| Symbol                  | Parameter                    | Test Conditions                                          | Rating |      |      | Units |
|                         |                              |                                                          | Min.   | Typ. | Max. |       |
| g <sub>fs</sub>         | Forward Trans conductance    | V <sub>DS</sub> =15V, I <sub>D</sub> =12.5A              | --     | 18   | --   | S     |
| C <sub>iss</sub>        | Input Capacitance            | V <sub>GS</sub> = 0V V <sub>DS</sub> = 25V<br>f = 1.0MHz | --     | 3487 | --   | pF    |
| C <sub>oss</sub>        | Output Capacitance           |                                                          | --     | 214  | --   |       |
| C <sub>rss</sub>        | Reverse Transfer Capacitance |                                                          | --     | 10   | --   |       |

| Resistive Switching Characteristics |                                |                                                                    |        |      |      |       |
|-------------------------------------|--------------------------------|--------------------------------------------------------------------|--------|------|------|-------|
| Symbol                              | Parameter                      | Test Conditions                                                    | Rating |      |      | Units |
|                                     |                                |                                                                    | Min.   | Typ. | Max. |       |
| t <sub>d(ON)</sub>                  | Turn-on Delay Time             | I <sub>D</sub> =25A V <sub>DD</sub> = 250V<br>R <sub>G</sub> =10Ω  | --     | 37.2 | --   | ns    |
| t <sub>r</sub>                      | Rise Time                      |                                                                    | --     | 64.4 | --   |       |
| t <sub>d(OFF)</sub>                 | Turn-Off Delay Time            |                                                                    | --     | 86.8 | --   |       |
| t <sub>f</sub>                      | Fall Time                      |                                                                    | --     | 46   | --   |       |
| Q <sub>g</sub>                      | Total Gate Charge              | I <sub>D</sub> =25A V <sub>DD</sub> =400V<br>V <sub>GS</sub> = 10V | --     | 64   | --   | nC    |
| Q <sub>gs</sub>                     | Gate to Source Charge          |                                                                    | --     | 17   | --   |       |
| Q <sub>gd</sub>                     | Gate to Drain (“Miller”)Charge |                                                                    | --     | 23   | --   |       |



| Source-Drain Diode Characteristics |                                        |                                                                                                 |        |      |      |       |
|------------------------------------|----------------------------------------|-------------------------------------------------------------------------------------------------|--------|------|------|-------|
| Symbol                             | Parameter                              | Test Conditions                                                                                 | Rating |      |      | Units |
|                                    |                                        |                                                                                                 | Min.   | Typ. | Max. |       |
| I <sub>S</sub>                     | Continuous Source Current (Body Diode) |                                                                                                 | --     | --   | 25   | A     |
| I <sub>SM</sub>                    | Maximum Pulsed Current (Body Diode)    |                                                                                                 | --     | --   | 100  | A     |
| V <sub>SD</sub>                    | Diode Forward Voltage                  | I <sub>S</sub> =25A,V <sub>GS</sub> =0V                                                         | --     | --   | 1.5  | V     |
| t <sub>rr</sub>                    | Reverse Recovery Time                  | I <sub>S</sub> =25A,T <sub>j</sub> = 25℃<br>dI <sub>F</sub> /dt=100A/us,<br>V <sub>GS</sub> =0V | --     | 490  | --   | ns    |
| Q <sub>rr</sub>                    | Reverse Recovery Charge                |                                                                                                 | --     | 6246 | --   | nC    |
| I <sub>RRM</sub>                   | Reverse Recovery Current               |                                                                                                 | --     | 25.5 | --   | A     |
| Pulse width tp≤300μs, δ ≤2%        |                                        |                                                                                                 |        |      |      |       |

| Symbol          | Parameter           | Max. | Units        |
|-----------------|---------------------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case    | 0.42 | $^\circ C/W$ |
| $R_{\theta JA}$ | Junction-to-Ambient | 40   | $^\circ C/W$ |

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup>:  $L=10mH, I_D=17.3A, \text{Start } T_j=25^\circ C$

<sup>a3</sup>:  $I_{SD}=25A, di/dt \leq 100A/us, V_{DD} \leq BV_{DS}, \text{Start } T_j=25^\circ C$



## Characteristics Curve:

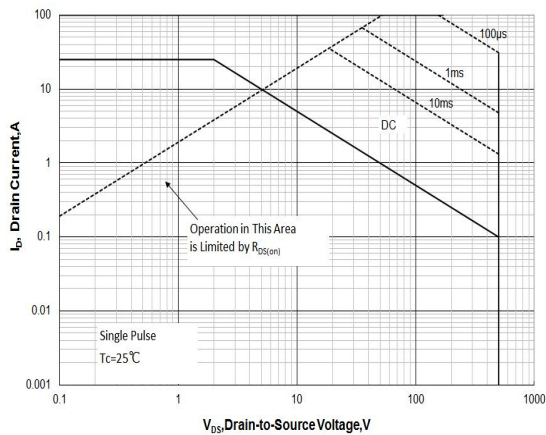


Figure 1 Maximum Forward Bias Safe Operating Area

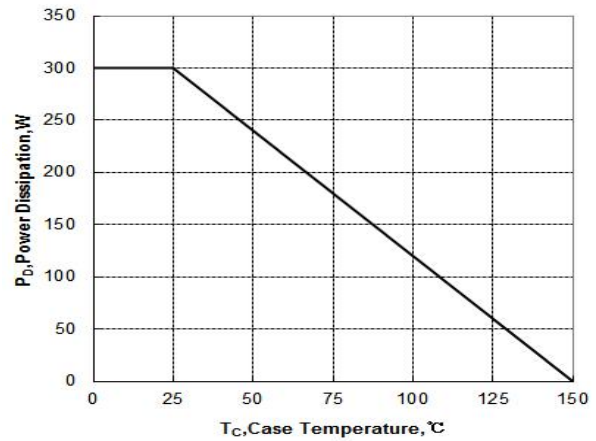


Figure 2 Maximum Power dissipation vs Case Temperature

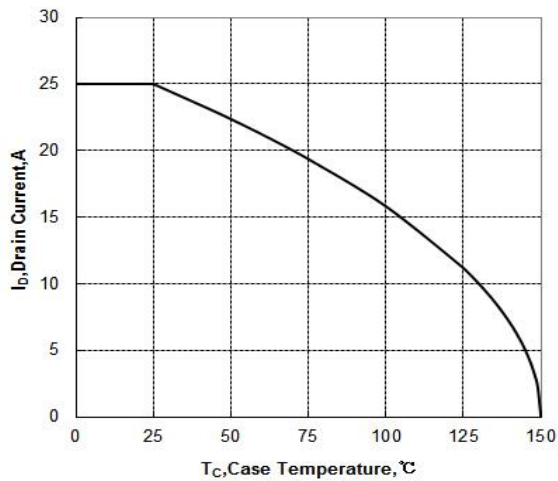


Figure 3 Maximum Continuous Drain Current vs Case Temperature

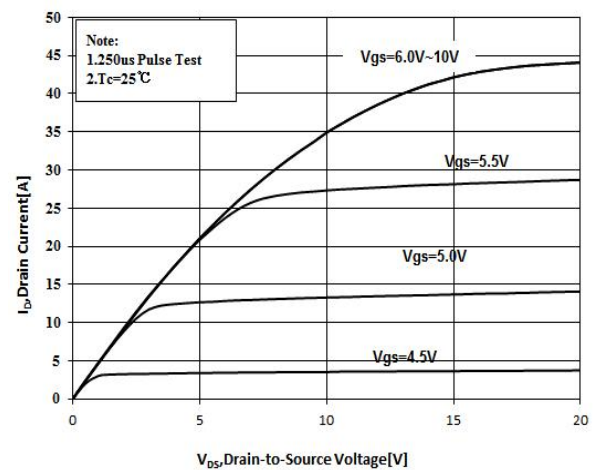


Figure 4 Typical Output Characteristics

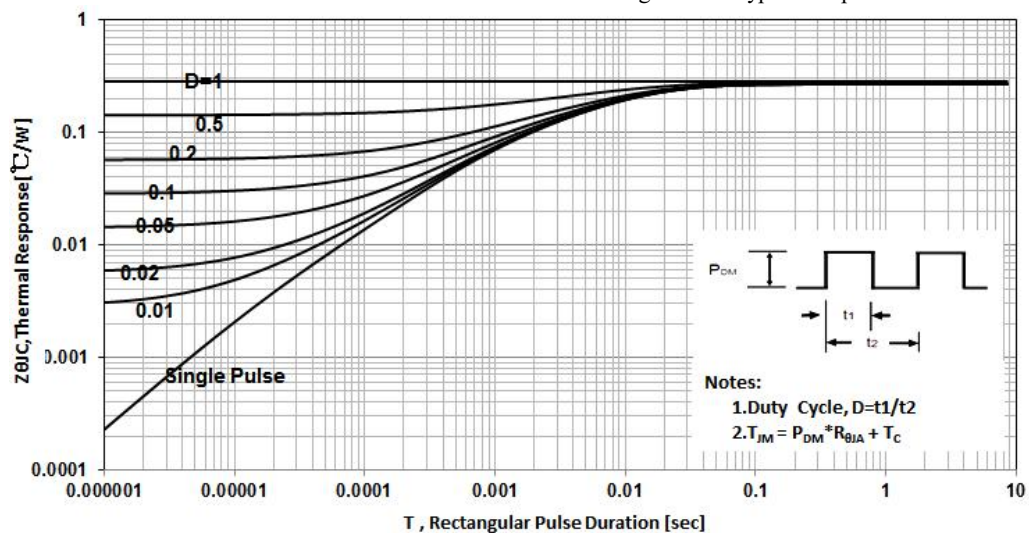


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

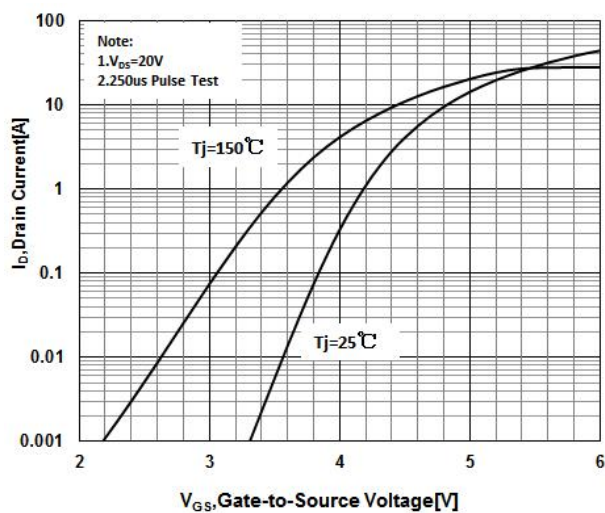


Figure 6 Typical Transfer Characteristics

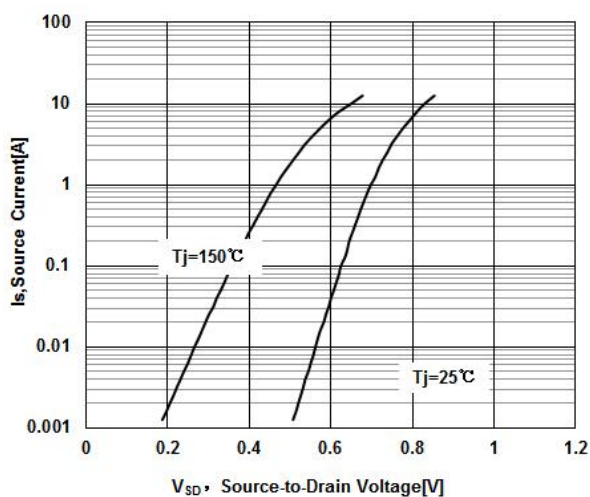


Figure 7 Typical Body Diode Transfer Characteristics

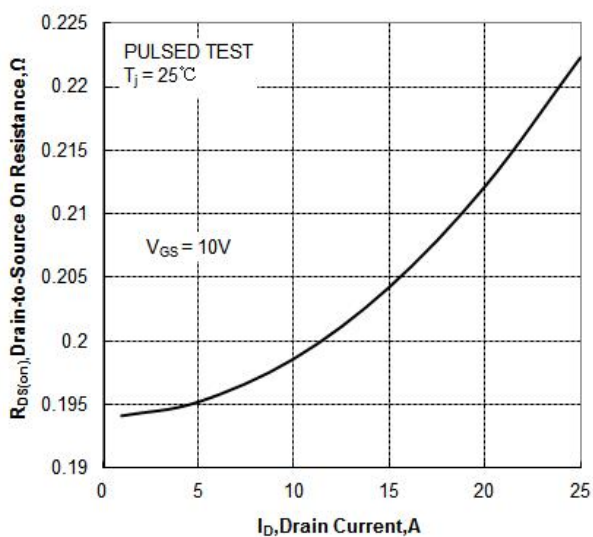


Figure 8 Typical Drain to Source ON Resistance vs Drain Current

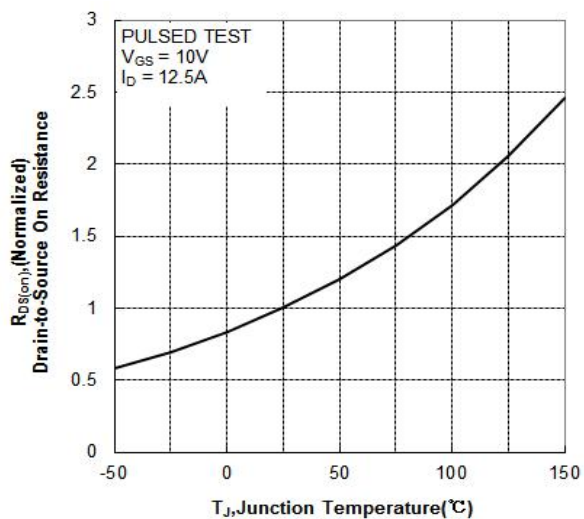


Figure 9 Typical Drain to Source on Resistance vs Junction Temperature

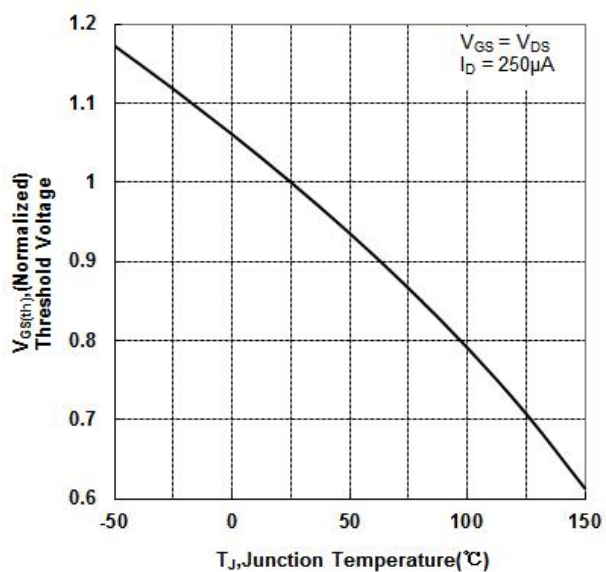


Figure 10 Typical Theshold Voltage vs Junction Temperature

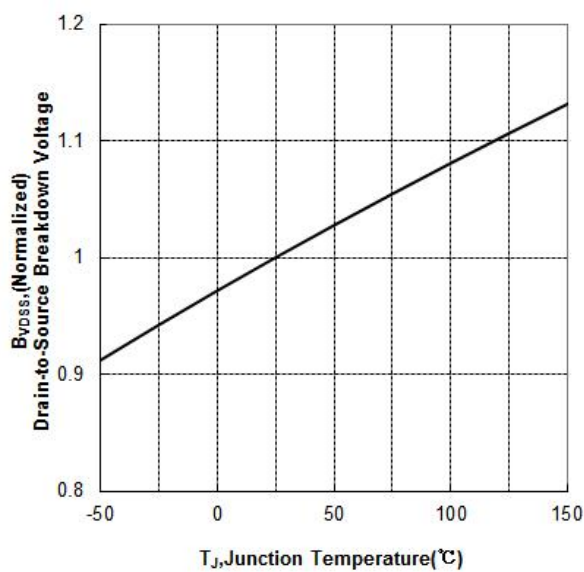


Figure 11 Typical Breakdown Voltage vs Junction Temperature

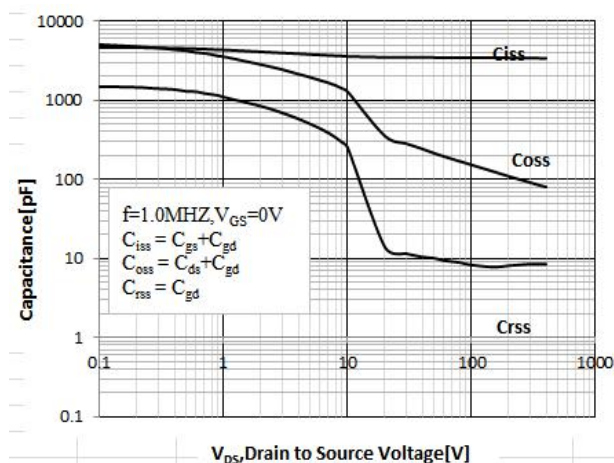


Figure 12 Typical Capacitance vs Drain to Source Voltage

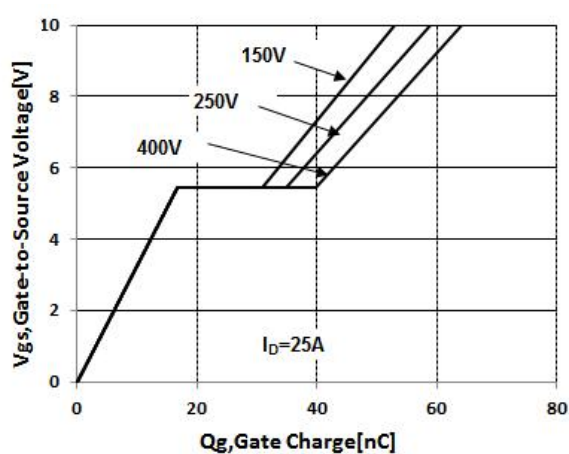


Figure 13 Typical Gate Charge vs Gate to Source Voltage

## Test Circuit and Waveform:

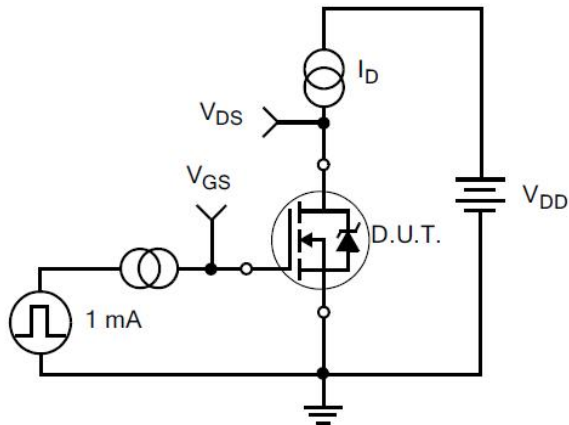


Figure 14. Gate Charge Test Circuit

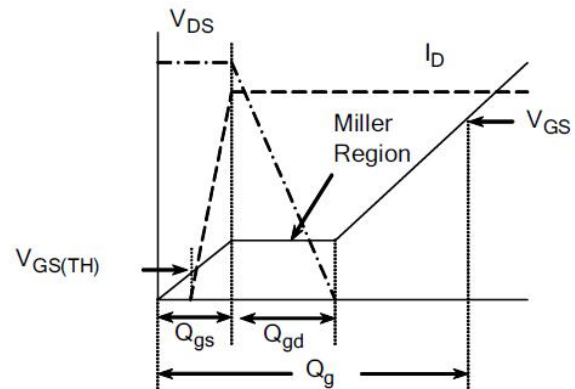


Figure 15. Gate Charge Waveforms

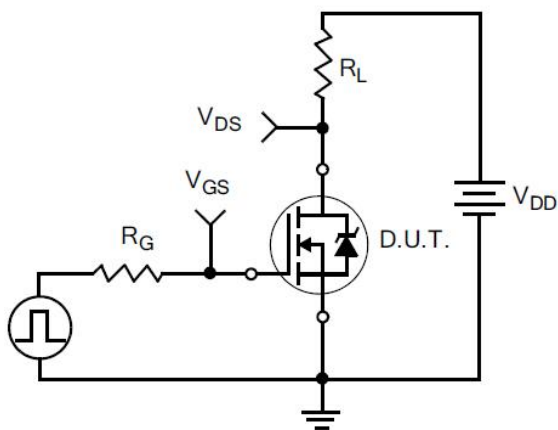


Figure 16. Resistive Switching Test Circuit

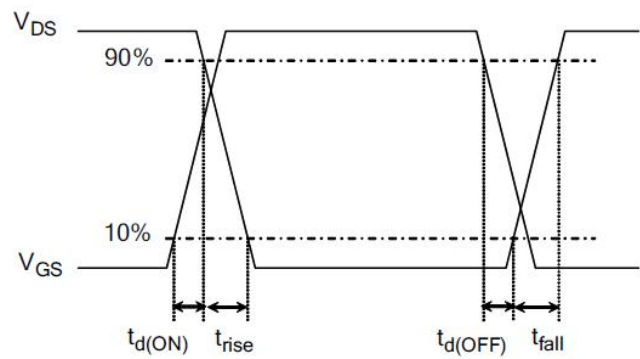


Figure 17. Resistive Switching Waveforms



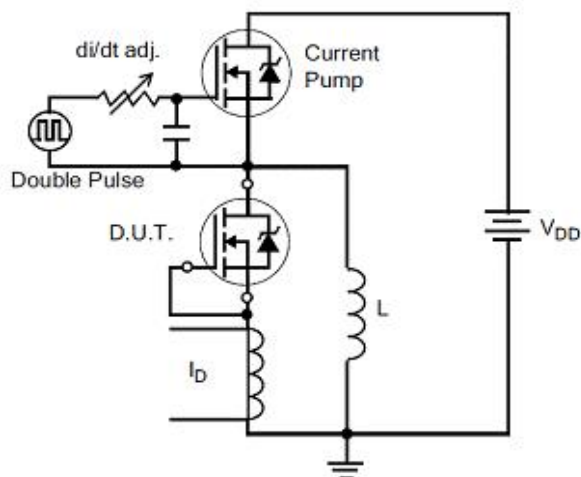


Figure 18. Diode Reverse Recovery Test Circuit

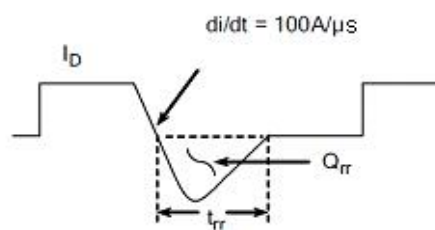


Figure 19. Diode Reverse Recovery Waveform

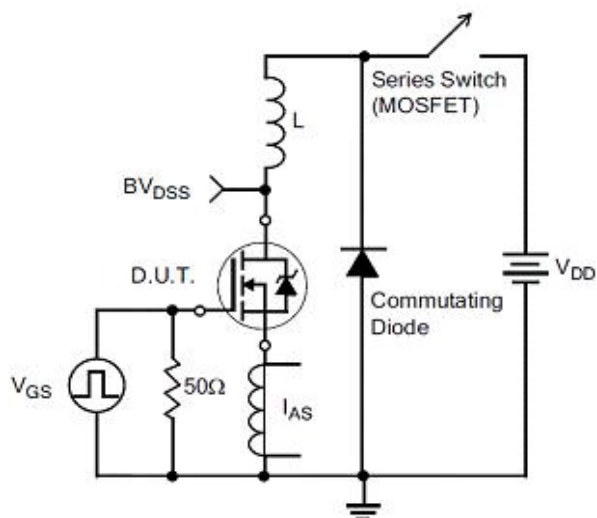


Figure20.Unclamped Inductive Switching Test Circuit

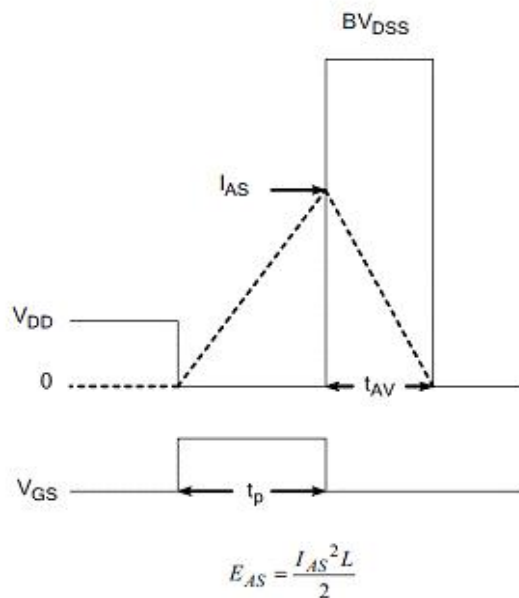
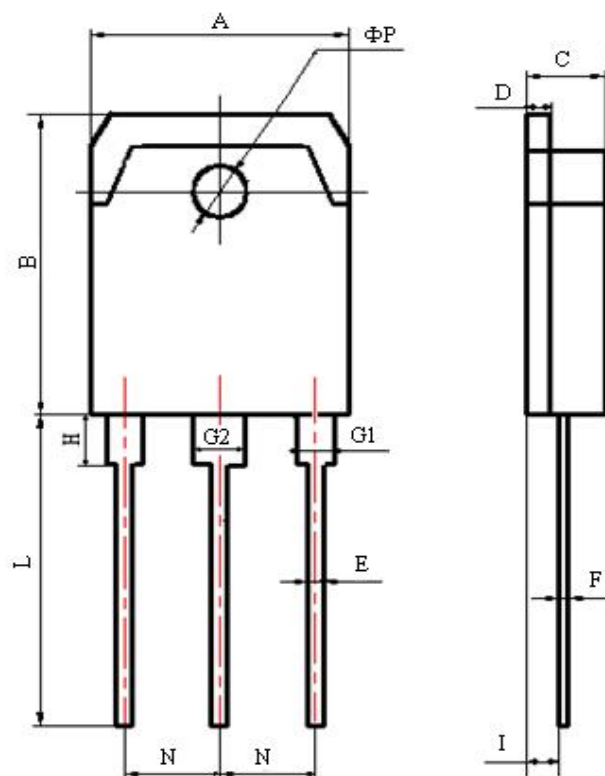


Figure21.Unclamped Inductive Switching Waveform



**Package Information:**

| Items | Values(mm) |       |
|-------|------------|-------|
|       | MIN        | MAX   |
| A     | 15.00      | 16.00 |
| B     | 19.20      | 20.60 |
| C     | 4.60       | 5.00  |
| D     | 1.40       | 1.60  |
| E     | 0.90       | 1.10  |
| F     | 0.50       | 0.70  |
| G1    | 2.00       | 2.20  |
| G2    | 3.00       | 3.20  |
| H     | 3.00       | 3.70  |
| I     | 1.20       | 1.70  |
|       | 2.70       | 2.90  |
| L*    | 19.00      | 21.00 |
| N     | 5.25       | 5.65  |
| Φ P   | 3.10       | 3.30  |

\*: adjustable

**TO-3P(N) Package**



## Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
2. When installing the heatsink, please pay attention to the torsional moment and the smoothness of the heatsink.
3. VDMOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. This publication is made by Huajing Microelectronics and subject to regular change without notice.

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| Revision History |           |               |
|------------------|-----------|---------------|
| Revision         | Date      | Major changes |
| 1.0              | 2026/4/13 | Update logo   |